## Notice of References Cited

Application/Control No.

09/765,388

Examiner

David A Vanore

Applicant(s)/Patent Under
Reexamination
SHIMAZU ET AL.

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5742062-A	04-1998	Stengl et al.	250/396R
	В	US-5939725-A	08-1999	Muraki	250/492.22
	С	US-5770862-A	06-1998	Ooaeh et al.	250/398
	D	US-5391886-A	02-1995	Yamada et al.	250/492.22
	Ε	US-5874739-A	02-1999	Buschbeck et al.	250/396R
	F	US-			
	G	US-			
	Н	US-			
	1	US-	,		
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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